

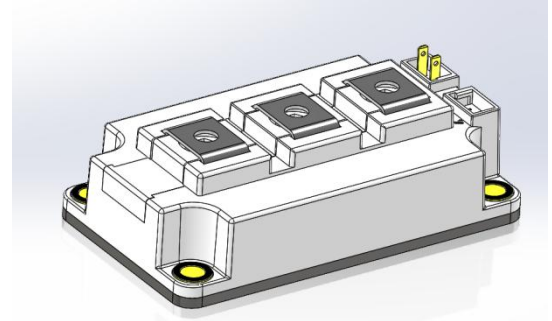
JLFD300B170R62E7DN

62 PACK module with Trench/Fieldstop IGBT and Emitter Controlled diode



Features

- Low $V_{CE(sat)}$ Trench IGBT technology
- High creepage and clearance distances
- $V_{CE(sat)}$ with positive temperature coefficient
- Maximum junction temperature 175°C
- Package with CTI>400

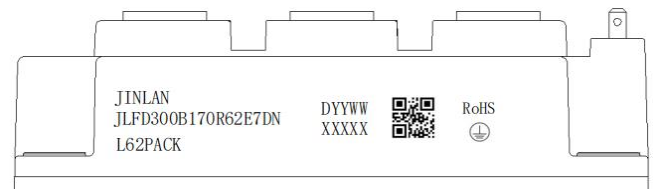


62 Pack

Typical Applications

- 3-level-applications
- Motor Drives
- Chopper application

MARKING DIAGRAM



JINLAN

JLFD300B170R62E7DN

DYYWW

XXXXX

QR code

= Company Name

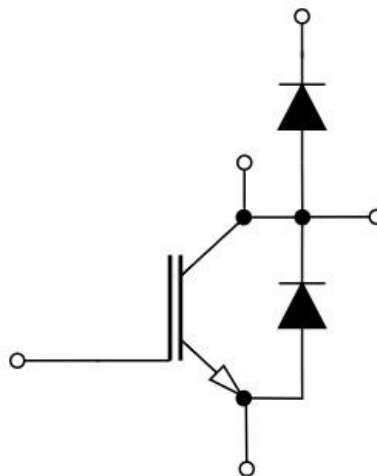
= Specific Device Code

= Year and Work Week Code

= Serial Number

= Custom Assembly

Description





Package Insulation coordination

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	V_{ISOL}	RMS, f=50 Hz, t=60 s	4.0	kV
Internal isolation		basic insulation(class 1, IEC 61140)	Al_2O_3	
Creepage distance	d_{creep}	terminal to heatsink	29.0	mm
Creepage distance	d_{creep}	terminal to terminal	23.0	mm
Clearance	d_{clear}	terminal to heatsink	23.0	mm
Clearance	d_{clear}	terminal to terminal	11.0	mm
Comparative tracking index (electrical)	CTI		>400	

Package Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Stray Inductance	L_{CE}			--	20	--	nH
Module Lead Resistance, Terminal to Chip	R_{CC+EE}			--	0.70	--	mΩ
Storage temperature	T_{stg}			-40	--	125	°C
Mounting torque for module mounting	M	-Mounting according to valid application note	M6, Screw	3.00	--	6.00	Nm
Terminal connection torque	M	-Mounting according to valid application note	M6, Screw	2.5	--	5.0	Nm
Weight	G			--	340	--	g



IGBT , Brake-Chopper

Absolute Maximum Ratings ($T_c = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Description	Value	Unit
V_{CES}	Collector-Emitter Voltage	1700	V
V_{GES}	Gate-Emitter Voltage	± 30	V
I_{CDC}	Continuous Collector Current @ $T_c = 80^\circ\text{C}$ ($T_{vj\max} = 175^\circ\text{C}$)	300	A
I_{CM}	Pulsed Collector Current, $t_p = 1\text{ ms}$	600	A
$T_{vj\max}$	Maximum Junction Temperature	175	$^\circ\text{C}$

Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Condition		Min	Typ	Max	Unit
V _{CE(sat)}	Collector–Emitter Saturation Voltage	I _C =300A, V _{GE} = 15V	T _{vj} = 25 °C	--	1.75	2.20	V
			T _{vj} = 150 °C	--	2.20	--	
V _{GE(TH)}	Gate–Emitter Threshold Voltage	I _C =12mA, V _{CE} =V _{GE}		4.80	5.40	6.50	V
I _{CES}	Collector–Emitter Cutoff Current	V _{GE} = 0 V, V _{CE} = 1700V		--	--	100	μA
I _{GES}	Gate-Emitter Leakage Current	V _{GE} = ±30 V, V _{CE} = 0 V, T _{vj} = 25°C		--	--	100	nA
R _{Gint}	Internal Gate Resistance	f=1MHz		--	4.37	--	Ω
C _{ies}	Input Capacitance	V _{CE} =25V, V _{GE} =0V, f=1MHz		--	12.5	--	nF
C _{res}	Reverse Transfer			--	0.21	--	nF
Q _G	Gate Charge	V _{CC} = 900 V, V _{GE} =15 V		--	1.05	--	μC
t _{d(on)}	Turn–On Delay Time	V _{CE} = 900 V, I _C =300 A, R _{Gon} = 10Ω, R _{Goff} = 15Ω V _{GE} =±15V Inductive Load T _{vj} = 25°C		--	0.40	--	μs
t _r	Rise Time			--	0.13	--	
t _{d(off)}	Turn–off Delay Time			--	1.36	--	
t _f	Fall Time			--	0.25	--	
E _{on}	Turn–On Switching Loss per Pulse			V _{CE} = 900 V, I _C =300 A, R _{Gon} = 10Ω, R _{Goff} = 15Ω V _{GE} =±15V Inductive Load T _{vj} = 150°C		--	141.5
E _{off}	Turn Off Switching Loss per Pulse	--	83.8			--	
t _{d(on)}	Turn–On Delay Time	--	0.39			--	μs
t _r	Rise Time	--	0.17			--	
t _{d(off)}	Turn–off Delay Time	--	1.53			--	
t _f	Fall Time	V _{CE} = 900 V, I _C =300 A, R _{Gon} = 10Ω, R _{Goff} = 15Ω V _{GE} =±15V Inductive Load T _{vj} = 150°C		--	0.45	--	mJ
E _{on}	Turn–on Switching Loss per Pulse			--	194.4	--	
E _{off}	Turn Off Switching Loss per Pulse			--	114.5	--	
I _{C(sc)}	SC Data	t _p ≤10 μs, V _{GE} ≤15 V, T _{vj} ≤150 °C, V _{CC} =1000 V, V _{CEmax} =V _{CES} -L _{SCE} •di/dt		--	1259	--	A
R _{thJC}	Thermal resistance	Junction-to-Case (per IGBT)			0.120		K/W
T _{vj op}	Temperature under switching conditions			-40		175 ¹⁾	°C

¹⁾ $T_{vj\text{ op}} > 150^\circ\text{C}$ is only allowed for operation at overload conditions. For detailed specifications please refer to AN 2018-14.



Diode , Brake-Chopper

Absolute Maximum Ratings (T_c = 25°C unless otherwise noted)

Symbol	Description	Value	Unit
V _{RRM}	Repetitive Peak Reverse Voltage	1700	V
I _F	Diode Continuous Forward Current	300	A
I _{FM}	Diode Maximum Forward Current, t _p =1ms	600	A

Characteristics (T_c = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
V _F	Diode Forward Voltage	I _F = 300 A, T _{vj} =25°C	--	1.60	2.10	V
		I _F =300 A, T _{vj} =150°C	--	1.75	--	
T _{rr}	Reverse Recovery Time	V _{CE} =900 V, V _{GE} =-15 V, I _F =300 A T _{vj} = 25°C	--	0.85	--	μs
I _{RM}	Peak Reverse Recovery Current		--	234	--	A
Q _{rr}	Recovered Charge		--	71	--	μC
E _{rec}	Reverse Recovery Energy		--	29.2	--	mJ
T _{rr}	Reverse Recovery Time	V _{CE} =900 V, V _{GE} = -15 V I _F =300 A T _{vj} = 150°C	--	1.39	--	ns
I _{RM}	Peak Reverse Recovery Current		--	221	--	A
Q _{rr}	Recovered Charge		--	117	--	μC
E _{rec}	Reverse Recovery Energy		--	54.3	--	mJ
R _{thJC}	Thermal resistance	Junction-to-Case (per diode)		0.180		K/W
T _{vj op}	Temperature under switching conditions		-40		175 ²⁾	°C

²⁾T_{vj op} > 150°C is only allowed for operation at overload conditions. For detailed specifications please refer to AN 2018-14.

Diode , Reverse

Absolute Maximum Ratings (T_c = 25°C unless otherwise noted)

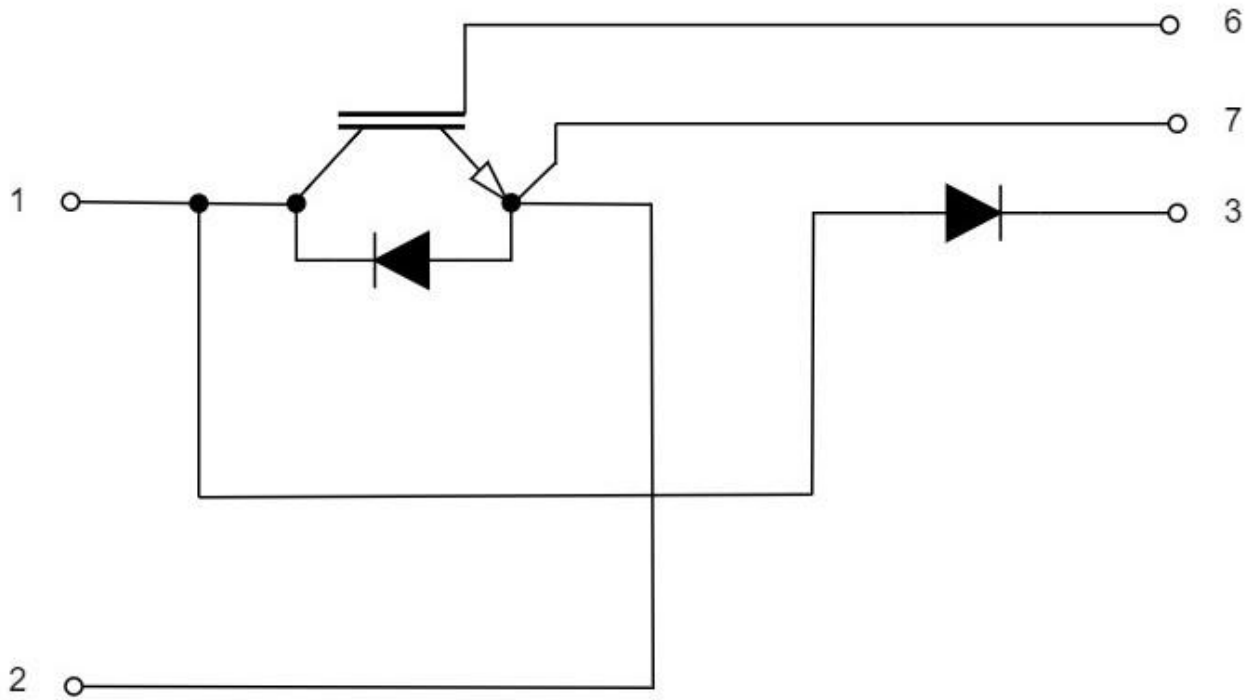
Symbol	Description	Value	Unit
V _{RRM}	Repetitive Peak Reverse Voltage	1700	V
I _F	Diode Continuous Forward Current	300	A
I _{FM}	Diode Maximum Forward Current t _p =1ms	600	A

Characteristics (T_c=25°C unless otherwise noted)

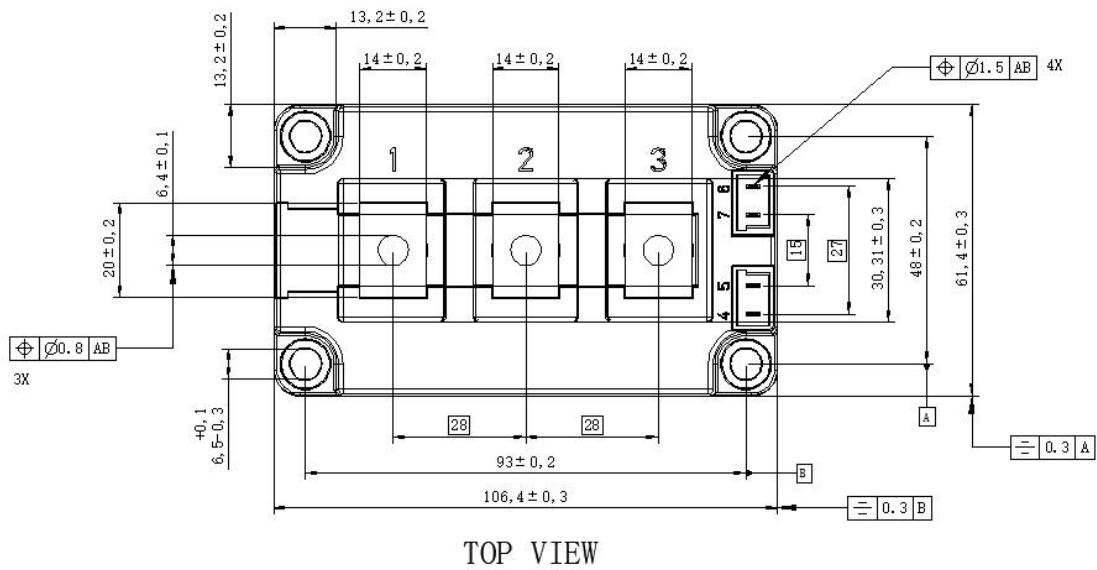
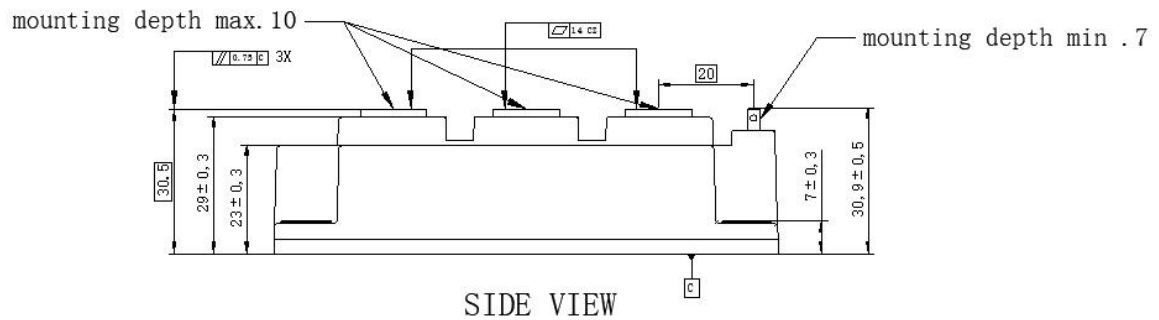
Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
V _F	Diode Forward Voltage	I _F = 300 A, T _{vj} = 25°C	--	1.60	2.10	V
		I _F = 300 A, T _{vj} = 175°C	--	1.75	--	
R _{thJC}	Thermal resistance	Junction-to-Case (per diode)	--	0.180		K/W
T _{vj op}	Temperature under switching conditions		-40		175 ³⁾	°C

³⁾T_{vj op} > 150°C is only allowed for operation at overload conditions. For detailed specifications please refer to AN 2018-14.

CIRCUIT DIAGRAM



PACKAGE DIMENSION





REVISION HISTORY

Document version	Date of release	Description of changes
Rev.00	2024-09-23	Preview



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